

Surface-Modified Group I–III–VI Semiconductor Colloidal Quantum Dots with Customized Photoluminescence and Enhanced Electronic Properties

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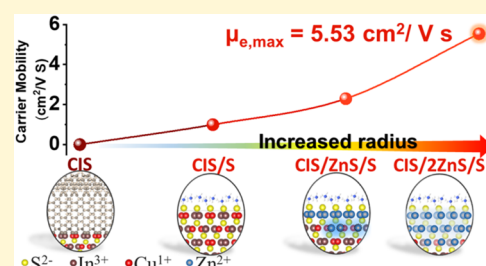
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ABSTRACT: Group I–III–VI semiconductor colloidal quantum dots (QDs) emerge as an exciting family of nanocrystals increasingly attractive for the next-generation solution-processed optoelectronic devices thanks to their low-cost synthesis and environmentally friendly, Cd- and Pb-free compositions. Here, a universal approach based on room-temperature surface treatment and cation exchange has been demonstrated to modify the surface and composition of CuInS₂, CuInSe₂ and AgInS₂ QDs. The absorption cross-section was enhanced and the emerging photoluminescence properties were finely tuned in the near-infrared region owing to great control over the size and composition of the modified QDs. While the field-effect transistors (FETs) based on the original untreated QDs exhibit *p*-type behavior and suffer from low hole mobility (μ_h), surface passivation of these QDs with an inorganic layer of S²⁻ leads to a clear switch to *n*-type behavior accompanied by a great enhancement in electron mobility (μ_e). Moreover, additional diffusion of Zn atoms into the structure heals the acceptor sites and nullifies the effect of metal vacancies and antisite defects. The FET devices based on the final modified CuInS₂ and AgInS₂ QDs demonstrate exceptionally high μ_e of 5.53 and 7.50 cm² V⁻¹ s⁻¹, respectively, 4 orders of magnitude higher than μ_h of the starting untreated QDs.



INTRODUCTION

Colloidal quantum dots (QDs) of group I–III–VI semiconductors make an exciting class of solution-processed nanocrystals (NCs) and have recently been attracting significant attention owing to their versatile synthesis and broad optoelectronic applications.^{1–3} The soft crystalline structure of these QDs allows for heavy doping and alloying of their structure, which opens the door for vastly different compositions from simple ternary, such as CuInS₂ (CIS), CuInSe₂ (CISE) and AgInS₂ (AIS),^{4–7} to Mn²⁺ and Al³⁺ doped compositions,^{8–10} and further to quaternary compositions such as CuAgInS₂ and CuInSeS.^{11,12} Characterized by their broadband, high quantum yield (PLQY) photoluminescence (PL) and extended coverage of optical absorption,^{13–15} these QDs offer great potential for a vast range of optoelectronic applications.^{16–26}

One effective method to tune and enhance the properties of these QDs is to coat an inorganic shell that prevents the excitons from reaching the surface.^{27,28} This electronic structure, known as quasi-type-II,²⁹ is usually obtained through thermal decomposition of Cd or Zn precursors at relatively high temperatures, which causes the diffusion and exchange of Zn or Cd, accompanied by final shell deposition.^{28,30,31} The literature on ZnS shell growth is focused on either single-pot or seed-mediated synthesis methods,^{15,32} whereas implementing cation exchange was limited to the full exchange of the host

atoms.^{33,34} However, partial cation exchange during the shell deposition can also play a central role in the final optoelectronic properties of the QDs.^{35–37}

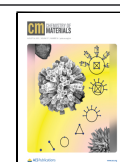
The solution-based QDs of group I–III–VI make an excellent candidate for the next-generation flexible thin-film transistors as a potential alternative to conventional polycrystalline silicon transistors, which require high-temperature processing.^{38–40} While most of the previous electronics studies had focused on the Cd- or Pb-based devices, it was not until recently that efforts to engineer I–III–VI QDs started to grow. CIS and CISE QDs are usually known for their *p*-type behavior originating from their internal point defects due to the partial solid solution miscibility of Cu₂S and In₂S₃,⁴¹ which produces metal vacancy defects of Cu and In and those of Cu in In (Cu_{In}) antisite defects.⁴² Moreover, the surface of these QDs is covered with an unsaturated metal layer, which is known to trap charge carriers.⁴³ With their low hole mobility further exacerbated by the original long and bulky ligands,⁴⁴ surface

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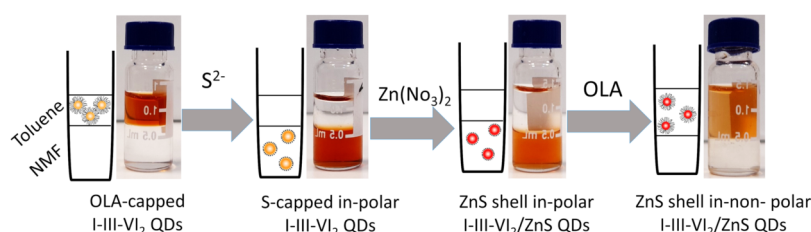


Figure 1. Schematic and the real images of the CIS QDs solution showing the synthesis steps for surface treatment of the I–III–VI QDs. First, the original QDs with long-chain OLA ligands are stably dispersed in a nonpolar solvent. The ligands are replaced with S^{2-} and the QDs are transferred to the polar solvent of NMF. The S-terminated QDs are treated with a solution of $Zn(NO_3)_2$ -NMF, and at the end, the QDs are transferred back to toluene by introducing OLA.

and composition modifications are imperative to obtain QDs applicable for device applications that require high carrier mobility.

One strategy to increase the carrier mobility is to replace the long-chain ligands with shorter ones, which effectively decreases the proximity of the QDs.^{45–49} In the absence of charge doping, this strategy yields higher carrier mobility, which is especially important for *p*-type QDs.⁵⁰ Shorter ligands, including halides^{50,51} (Cl^- , Br^- and I^-), chalcogenides⁵² (S^{2-} , Se^{2-} and Te^{2-}), pseudohalogens⁵³ (OCN^- , SCN^- , OH^- and SH^-), chalcogenidometallates⁵⁴ ($As_2S_3^-$) and short-chain organic ligands^{55–57} (2-ethylhexane-1-thiol (EHT) and 1-octanethiol (OT), conjugated ligands) have been successfully used for a wide range of QDs, resulting in higher carrier mobility. The transport behavior and free carrier density can be tuned through composition modification with an injection of a negative or a positive charge.^{42,49} The soft lattice of I–III–VI QDs allows heavy alteration and easy diffusion and exchange of atoms necessary to neutralize the acceptor sites and produce QDs with ambipolar or *n*-type behavior.⁴² The post-treatment of QD thin film at elevated temperatures in the presence of an In source allows injection of extra negative charge and interdiffusion of the QDs on the film, which ultimately enhances μ_e to as high as $8.2 \pm 1.8 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ for CISE-based FETs.^{41,49} Recently, Pang et al. have also demonstrated the ability to change the charge balance by implementing extra layers of S^{2-} and showed enhanced μ_e of $9.6 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ for CISE QDs after high-temperature annealing of the QDs thin film at 350°C .⁵²

In this work, we propose and demonstrate a universal approach for the surface and composition modifications of group I–III–VI QDs based on the colloidal atomic layer deposition (c-ALD) technique and cation diffusion. Here, the original long-chain ligands were first removed, and subsequently, the surface of the QDs was passivated with the inorganic S^{2-} layer. Through the introduction of the Zn precursor, a shell of ZnS was formed on three sets of CIS, CISE and AIS QDs, which changed the PL emission peak wavelength and recombination dynamics and enhanced the absorption cross-section without changing the morphology of the QDs. This method was shown to be applicable for at least three cycles of surface treatment, in which the concentration of Zn continuously increases due to the growth and cation exchange. While the original CIS- and AIS-based devices show *p*-type behavior with poor electronic properties, the FETs based on the surface-modified QDs demonstrate *n*-type behavior with 4 orders of magnitude enhancement in their carrier mobility. This synthetic approach is especially powerful as it addresses the main causes of low carrier mobility by replacing the bulky ligands with short inorganic ligands,

incorporating a surface donor layer and passivating the bulk acceptor antisite and vacancy defects through the diffusion of Zn. The final Se-free FETs exhibit electron mobility as high as 5.53 (CIS) and 7.50 (AIS) $\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ with an on/off ratio of $\sim 10^5$.

EXPERIMENTAL SECTION

Sequential MS (M: Cd or Zn) Shell Treatment of CIS, AIS and CISE QDs. For the shell coating of I–III–VI QDs (the synthesis method of the core QDs is provided in the Supporting Information), first, cation precursors were prepared by dissolving 4 mmol of zinc nitrate hexahydrate or cadmium nitrate tetrahydrate in 10 mL of NMF for Zn or Cd precursors, respectively. In a typical synthesis, the original core QDs were precipitated via the addition of extra ethanol and centrifugation and redispersed in 4 mL of hexane again. The solution contains 21 optical density (OD) of the QDs at the absorption wavelengths of 538, 528, and 571 nm for CIS, AIS and CISE QDs. Here, 1 OD corresponds to the volume of sample solution that results in 1 OD absorption at the given wavelengths when 25 μL of QDs solution is diluted in 3 mL of toluene. Four mL of NMF was added to this solution, which was phase separated from hexane and then, 120 μL of $(NH_4)_2S$ was added to terminate the QDs with a sulfur layer. The solution was stirred for 5 min until all QDs were transferred from hexane to NMF, and then hexane was removed with a plastic pipet. QDs were separated from extra unreacted sulfur precursor via the addition of toluene and acetonitrile and centrifugation at 5000 rpm for 3 min, and the precipitated QDs were redispersed in NMF. The cleaning process was repeated 3 times to make sure that all of the sulfur precursor was removed. Then, 1 mL of cation precursor was added to the solution and the solution was kept under stirring. After 30 min, an extra amount of toluene and acetonitrile was added, and the solution was centrifuged at 5000 rpm for 3 min to separate the QDs. The precipitate was redispersed in NMF and cleaned two more times. At this point, the first layer of MS shell is formed. In order to continue the shell growth, we repeated the above procedure. The final product was precipitated, and 5 mL of hexane and 1 mL of OLA were added to it to passivate the surface and transfer it back to a nonpolar solvent.

RESULTS AND DISCUSSION

To treat group I–III–VI QDs with ZnS, the c-ALD technique was employed, previously reported by Talapin's group.⁵⁸ In this method, each layer of anion or cation was separately introduced to the QDs, and before the deposition of the next layer, the unreacted chemicals were removed from the reaction medium.^{59,60} The method is known for its atomic precision, where reactive precursors can effectively form ionic bonds on the surface and increase the size of the QDs. The as-synthesized I–III–VI QDs capped with long-chain organic ligands are readily dispersible in nonpolar solvents. Throughout surface treatment, the ligands are first removed from the surface and replaced with short inorganic ligands that enable the QDs to be dispersed in polar solvents, in our case N-

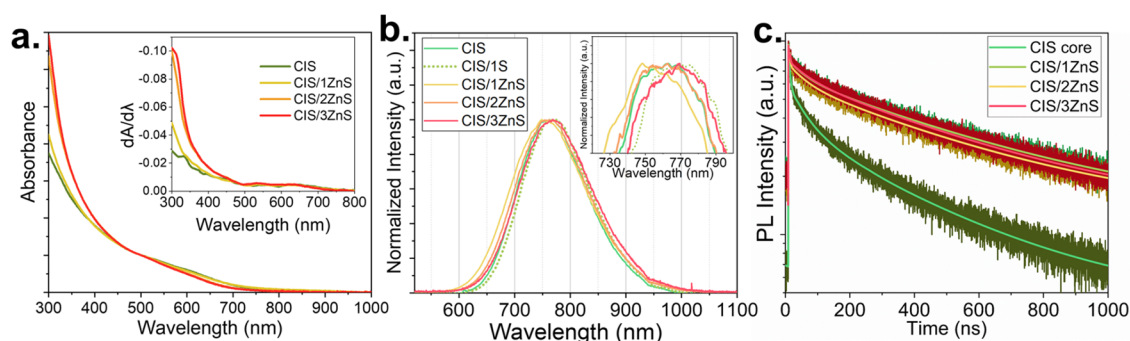


Figure 2. (a) Absorption and (b) PL spectra evolution of CIS-based QDs after a half-cycle treatment with S^{2-} and after three-time ZnS treatment. The inset in (a) presents the first derivative of the absorption spectra, and the inset in (b) displays the magnified PL peaks. (c) TRF decay curves and three-exponential fits (solid lines) of the same samples.

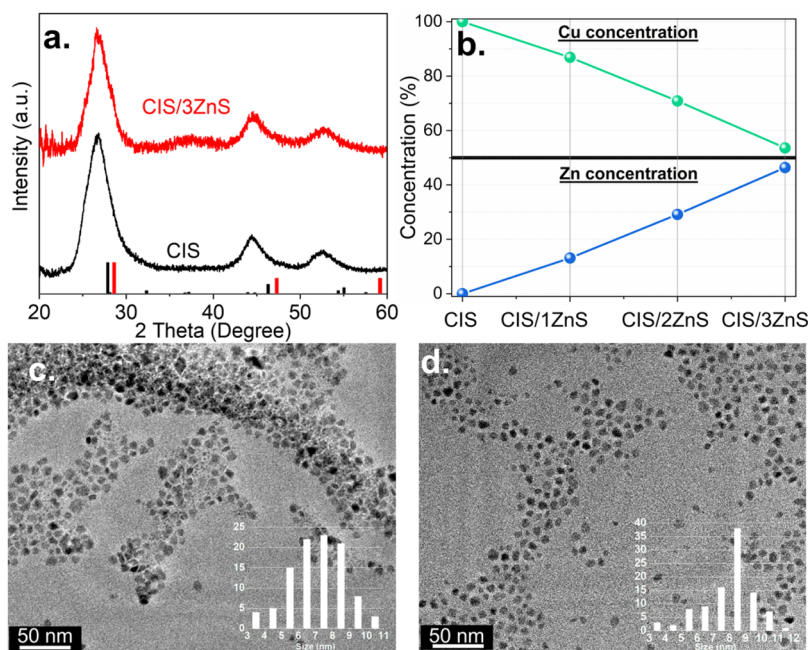


Figure 3. (a) Diffraction patterns of CIS and CIS/3ZnS QDs. Black and red bars are $CuInS_2$: ICDD 00–032–0339 and ZnS: ICDD 00–002–0564, respectively. (b) Evolution of Cu and Zn concentrations with each cycle of ZnS treatment measured via ICP-MS, in which the concentration of Zn linearly increases with the number of treatment cycles. (c) and (d) TEM image of CIS and CIS/3ZnS QDs, respectively. The insets are the size histograms of the corresponding images.

methanolformamide (NMF). Figure 1 shows a step-by-step schematic and photographs of the process for ZnS-treatment of the CIS QDs. As the QDs are terminated with a metal layer, sulfur ions, in the form of ammonium sulfide with much higher affinity, can replace the original ligands and form a sulfide layer around the QDs. The interparticle electrostatic force due to the surface S^{2-} ions also gives high colloidal stability in the polar solvent. After this half-reaction, the remaining nonpolar solvent was discarded, and until the final ligation stage, the whole process was carried out in NMF. The zinc precursor (zinc nitrate-NMF) was introduced to the S-terminated QDs so that the first layer of ZnS was formed. These two steps can be subsequently used to obtain the desired number of ZnS layers where the size can be sequentially increased. At the end, the QDs were transferred back to the nonpolar solvent through ligation with the long-chain organic oleylamine (OLA) ligand.

The absorption and PL spectra of CIS QDs after three-time ZnS treatment and final ligation are presented in Figure 2a,b, respectively. The absorption onsets of the samples exhibit no

obvious shift toward longer wavelengths; however, as ZnS possesses a wider bandgap and absorbs at relatively shorter wavelengths,⁶¹ an increase in the absorption below 500 nm was observed. This increase can also be observed in the first derivative of the spectra in the inset of Figure 2a. The PL spectra show a slight blue shift after 1 ML of ZnS and continuously red-shift toward longer wavelengths. This blue shift was predictable since the Zn^{2+} ions may diffuse in the lattice and fill the vacancy defect sites or exchange with Cu and In on the surface.⁶² Deposition of the extra shell layers only relaxes the confinement and induces a monotonic red shift of the PL. It is worth mentioning that after the deposition of the S^{2-} half-layer, a red shift in PL was observed due to an increase in size and relaxation of quantum confinement. The PLQY of the samples did not show much change during the three cycles of surface treatment (Table S1). This behavior can be attributed to the nature of the c-ALD method, which is prone to producing defects and possibly low PLQY, since it is generally performed at room temperature.⁶³

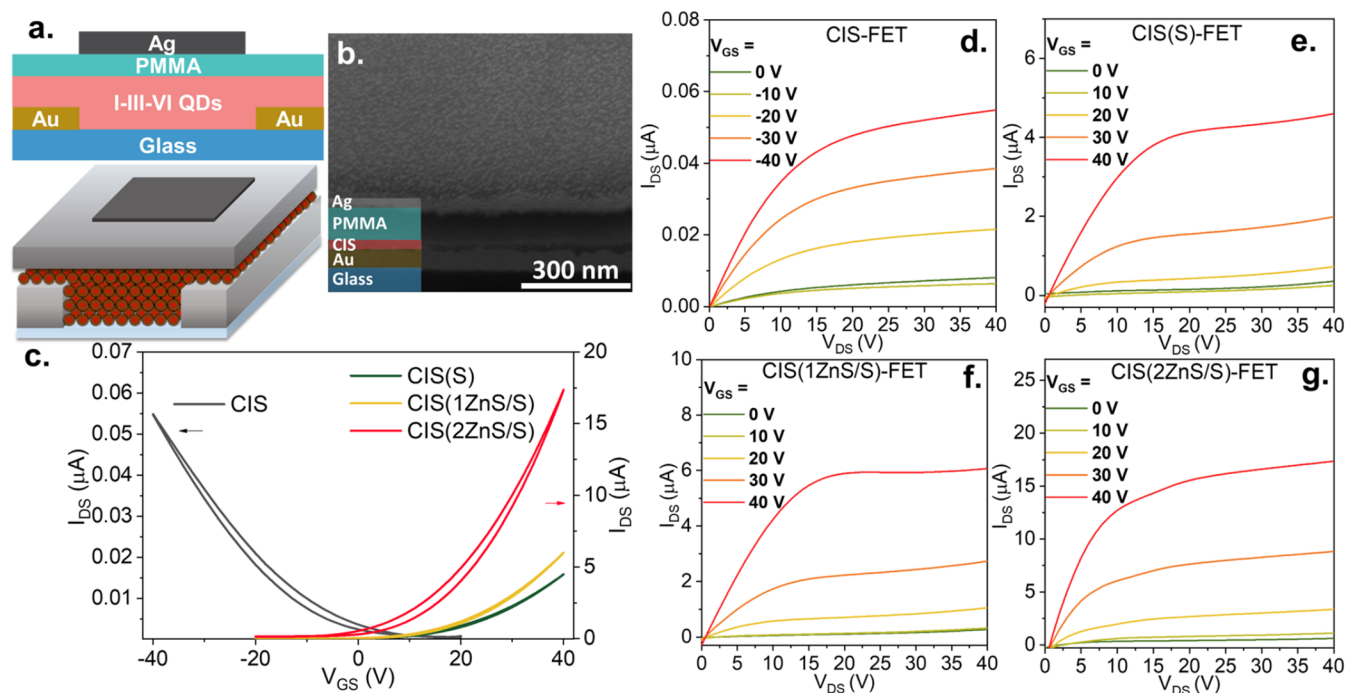


Figure 4. (a) QDs-FET device structure with top-gate/bottom-contact architecture on a glass substrate with interdigitated Au electrode. (b) Cross-sectional SEM image of the device with different layers having different contrasts. (c) Transfer characteristics (I_{DS} vs V_{GS}) of CIS-based FETs before and after surface treatment at saturation regime with V_{DS} of 20 and 40 V for original and surface-treated QDs, respectively. (d) Output characteristics (I_{DS} vs V_{DS}) of CIS-FET with long-chain OLA ligand and no surface treatment showing *p*-type behavior. (e) Output characteristics of CIS(S)-FET device after replacing the original ligands with small inorganic S^{2-} ions, showing a switch to *n*-type behavior. (f and g) Output characteristics of CIS(1ZnS/S)-FET and CIS(2ZnS/S)-FET after one and two cycles of ZnS treatment, respectively, and surface termination with S^{2-} . Both devices retained their nondegenerate *n*-type behavior.

The slight modification in the PL and absorption spectra of the samples is accompanied by a significant change in the excitonic recombination dynamics of the QDs. Figure 2c depicts the decay curves of the CIS and CIS/(1–3)ZnS QDs and their corresponding fitted lines with a three-exponential function (decay components are summarized in Table S2). The CIS core QDs have an intensity average lifetime (τ_{int}) of 351.2 ns. Upon treatment with ZnS, τ_{int} increases to 556.2 ns, 1.6 times longer than the original core. The change in the recombination dynamics points to a better passivation of the surface of the QDs, and an enlarged electron–hole distance, which increases the recombination lifetime.^{64–66} The lifetime of the half-treated QDs with S^{2-} is 376.1 ns (Figure S3 and Table S3), which is close to that of the untreated QDs. Further treatment with ZnS did not induce any meaningful change in the decay rate of the QDs, indicating similar excitonic behavior.

The crystalline structure of the CIS and CIS/3ZnS QDs was examined using X-ray diffraction (XRD) measurement (Figure 3a). The lattice constant of the original chalcopyrite CIS QDs depends on the Cu/In ratio with three high-intensity peaks evident in the diffraction pattern. The zinc blende ZnS and chalcopyrite CIS crystalline structures are very similar, and the only difference originates from the bication system of the chalcopyrite, which results in the elongation of the unit cell and loss of some of the symmetries. Treatment with 3 MLs of ZnS slightly shifts the peaks to higher angles ($\Delta\theta = 0.2^\circ$ for the first peak), closer to the diffraction peak of bulk ZnS. Moreover, the Zn diffusion into the lattice fills the vacancies, causes an exchange with Cu and In, and increases the share of zinc blende ZnS. The concentration of Zn, measured via

inductively coupled plasma mass spectrometry (ICP-MS), shown in Figure 3b, demonstrates a steady increase with each surface-treatment cycle. The average radius of the QDs has increased from 6.9 ± 1.7 nm for the CIS QDs (Figure 3c) to 8.7 ± 1.5 nm for the CIS/3ZnS QDs (Figure 3d), which accounts for 26% increase in the radius or 100% in the volume of the QDs.

We examined the applicability of the method for different I–III–VI core QDs. Herein, two classes of cores were synthesized: AIS QDs, with the Cu^+ ions replaced with Ag^+ , and CISe QDs, in which S^{2-} ions were replaced with Se^{2-} . Both sets of QDs exhibit absorption and PL evolutions similar to the ZnS-treated CIS QDs, while a slight change in the XRD peak positions was observed, and the morphology was largely conserved (detailed in the Supporting Information). Surface treatment of CIS QDs with CdS was also demonstrated, in which the higher chemical activity of Cd and lower conduction band offset of CdS compared to ZnS resulted in a much more pronounced shift in the PL spectra with a faster increase in the Cd content (detailed in the Supporting Information).

With the ease of synthesis and high versatility for surface and structural modifications, group I–III–VI QDs are promising candidates for the next-generation electronic devices. Herein, we implemented the surface-treated QDs as the active layer in field effect transistors (FETs) and examined their electronic properties based on their structural modifications. Figure 4a demonstrates a schematic of the top-gate/bottom-contact device on a glass substrate with an interdigitated Au electrode (the fabrication process is detailed in the Supporting Information). The fabricated FETs consist of CIS QDs (CIS-FETs), CIS/S QDs (CIS(S)-FETs), CIS/ZnS/S QDs

(CIS(1ZnS/S)-FETs) and CIS/2ZnS/S QDs (CIS(2ZnS/S)-FETs) as the active layer and poly(methyl methacrylate) (PMMA) layer as the gate dielectric. PMMA plays a critical role as the gate dielectric, influencing both the electrical and interfacial properties of the device. Primarily, it serves as an insulating layer that separates the gate electrode from the organic semiconductor, allowing efficient modulation of charge carriers without significant gate leakage. Owing to its moderate dielectric constant (~ 3.6), PMMA ensures a balance between low power consumption and sufficient gate control.⁶⁷ Additionally, PMMA provides a smooth and hydrophobic surface, which is essential for promoting the ordered growth and favorable morphology of the overlying semiconductor layer,⁶⁸ directly affecting the charge carrier mobility and reducing interface trap densities. Similarly, AIS-based FETs and CIS-based FETs treated with Cd were fabricated to compare their charge mobility performance.

The cross-sectional SEM image of an exemplary CIS-FET device in Figure 4b shows the morphology of the QDs active layer, in which a compact and crack-free CIS layer is formed. The same images of CIS(S)-FET in Figure S8 show a similar structure. For CIS-FET, the thicknesses of PMMA, QDs and Au layers are 89.0 ± 2.3 , 18.8 ± 2.3 and 57.4 ± 2.7 nm, respectively, closely matching the results from the CIS(S)-FET, which has the thicknesses of 85.2 ± 1.9 , 16.5 ± 1.8 and 57.7 ± 1.8 nm for PMMA, QDs and Au layers. The atomic force microscopy (AFM) image of the QDs film in Figure S9a,b confirms the formation of a smooth film with a root-mean-square roughness (R_{rms}) of 4.7 ± 2.6 nm for CIS-FET, and 5.3 ± 1.2 nm for CIS(S)-FET for a scan area of $5.0 \mu\text{m}^2$.

The original CIS, CISE and AIS cores are capped with long-chain ligands known to reduce the charge mobility or completely inhibit the gating effect in some cases.⁶⁹ Group I–III–VI QDs exhibit both *n*-type and *p*-type behavior depending on the nature and number of the defects.⁷⁰ For example, the deficiency in the chalcopyrite or cations results in vacancy sites in the crystal structure that can play a role as donors or acceptors, respectively, while the antisite defects, such as In_{Cu} (In replacing Cu in the lattice) and Cu_{In} , contribute as divalent donors and acceptors, respectively. The soft crystalline structure of I–III–VI QDs enhances the ion diffusion and chemical reactivity, critical for tailoring the charge transport behavior. It is worth mentioning that implementing different synthesis methods can affect the crystalline structure and defect density of the core QDs, which influences the electronic properties. However, even with a positive deviation of In/Cu in the composition of the core, the core-FETs still demonstrate *p*-type behavior. Here, the original cores are synthesized with the nonstoichiometric precursor ratio (In/Cu = 2:1, Supporting Information) to decrease the chance of Cu_{In} defects. We have shown the applicability of ligand exchange with $(\text{NH}_4)_2\text{S}$ and consecutive cation and anion treatment, which form an inorganic ZnS or CdS layer. Knowing that surface treatment alters the nature and number of crystal defects, we examined the electronic properties of the original and surface-treated QDs. The transfer (I_{DS} vs V_{GS}) and output characteristic (I_{DS} vs V_{DS}) of CIS-FETs with varying V_{GS} from 0 to -40 V, shown in Figure 4c,d, respectively, exhibit nondegenerate *p*-type behavior of the device modulated with the gate voltage. The CIS-FET device has a rather low charge mobility of $5.46 \times 10^{-4} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ and a poor on/off ratio of 0.8×10^2 , similar to the previous reports in the literature.⁴² The *p*-type behavior of the CIS QDs

indicates the excess number of hole in comparison to the electron, which is the result of deviation from the stoichiometric composition, usually in the form of In deficiency.

The surface treatment of the QDs removes the long-chain ligands and decreases the average distance between the QDs. The replacement of these ligands with shorter S^{2-} inorganic ligands was confirmed via Fourier-transform infrared spectroscopy (FTIR) measurement shown in Figure S10, in which the peak of bending vibration at 1462 cm^{-1} corresponding to OLA^{71,72} vanished after the first cycle, and the N–H stretching mode and NH_2 scissoring mode at 3300 and 1593 cm^{-1} are amplified, respectively. The complete phase transfer of the QDs from the nonpolar to polar solvent is another indication of the organic ligand removal (Figures 1 and S6). Moreover, the surface composition of the QDs was altered after sulfur and zinc treatment, which affects the stoichiometry of the QDs and the number of defects. The output characteristics of CIS(S)-FETs are shown in Figure 4e. Putting a layer of sulfur on the surface overturns the charge equilibrium and increases the density of the electrons. The unsaturated surface sites of the original QDs act as acceptors and increase the positive charge density, hence promoting the *p*-type behavior. The CIS(S)-FETs exhibit a switch from *p*-type to *n*-type due to the excessive number of electrons in the QDs. The device demonstrates an instant increase in the charge mobility to $0.99 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$, which is already $\sim 10^4$ times higher than the hole mobility of CIS-FETs. The on/off ratio of the device is also enhanced by 2 orders of magnitude to 3.2×10^4 compared to CIS-FETs (Table 1). The performance of these CIS-FET devices shows no change in behavior after 21 days of measurement (Figure S11).

Table 1. Device Characteristics of FETs Based on the Original CIS QDs, (0-2 ZnS/S) and (0-2 CdS/S) Surface-Treated CIS QDs, Original AIS QDs and (0-2 ZnS/S) Surface-Treated AIS QDs^a

FETs	μ_e/μ_h ($\text{cm}^2/\text{V s}$)	$I_{\text{on/off}}$	V_{Th} (V)
CIS(*)	5.46×10^{-4}	10^2	−6.4
CIS(S)	0.99	10^4	3.8
CIS(1ZnS/S)	2.29	10^5	2.7
CIS(2ZnS/S)	5.53	10^4	1.7
AIS(*)	3.44×10^{-4}	10^1	−20.0
AIS(S)	2.06	10^3	6.0
AIS(1ZnS/S)	4.57	10^4	5.6
AIS(2ZnS/S)	7.50	10^3	5.4
CIS(1CdS/S)	6.13	10^3	22.0
CIS(2CdS/S)	6.07	10^4	4.0

^aHere, μ_e and μ_h are the average measured electron and hole mobilities, respectively. $I_{\text{on/off}}$ is the on/off current ratio, and V_{Th} is the threshold voltage. Those indicated with (*) are the hole mobility of *p*-type devices and otherwise the electron mobility of *n*-type devices.

As mentioned, the *p*-type behavior is amplified by the cation-poor, especially In-poor, stoichiometry of the QDs. The Cu_{In} antisite defects also contribute to the density of the acceptor sites.⁵² On that account, if the number of cation vacancies or Cu_{In} antisite defects decreases, the electron mobility for *n*-type QDs should be enhanced. Examination of the electronic properties of CIS QDs treated with one and two layers of ZnS and terminated by S^{2-} half-layers confirms the nullification of the acceptor sites. The output characteristics of

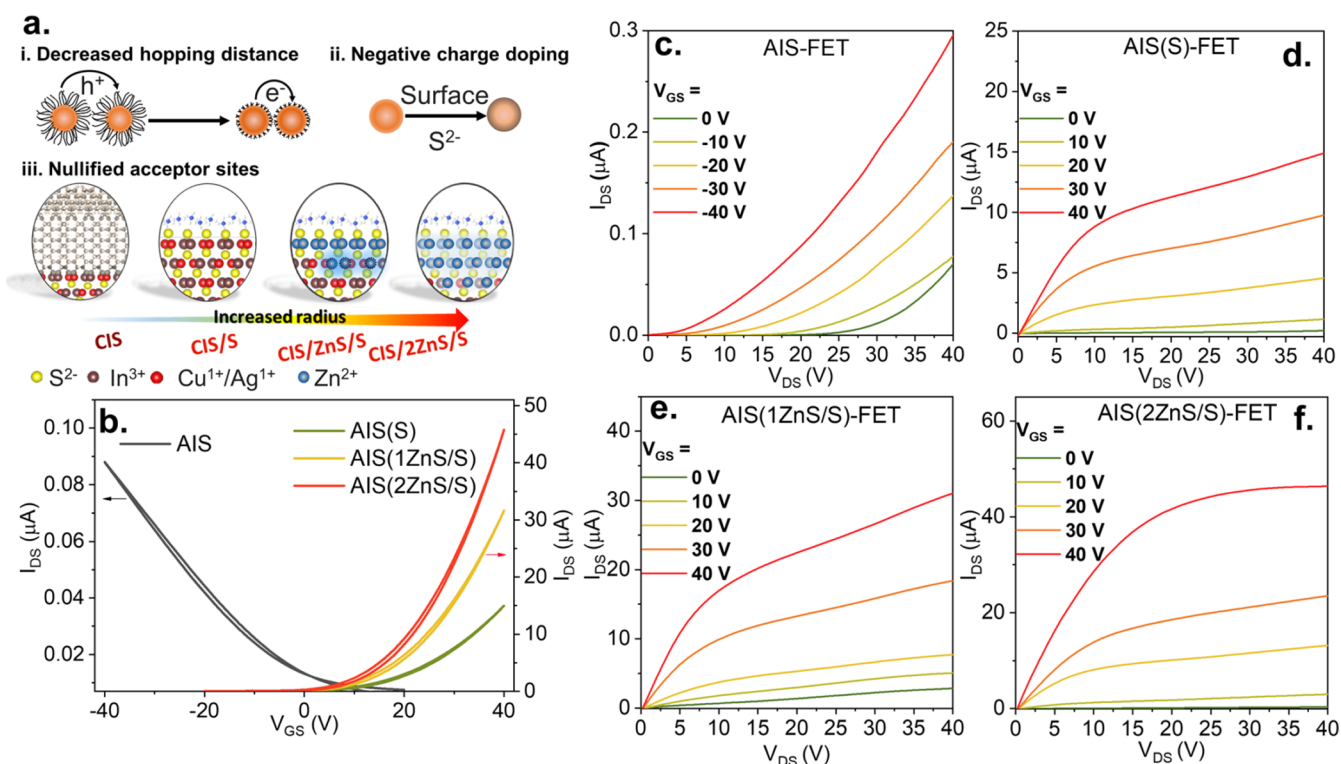


Figure 5. (a) Illustration of three main factors leading to enhancement of the carrier mobility: decreased hopping distance, negative charge doping, and nullification of the acceptor sites. (b) Transfer characteristics (I_{DS} vs V_{GS}) of AIS-based FETs before and after surface treatment at V_{DS} of 20 and 40 V, respectively. The device exhibits p -type behavior before surface treatment and switches to n -type after it. (c) Output characteristics of AIS-FET and (d) AIS(S)-FET with the OLA ligands replaced with short S^{2-} ions on the surface, which induces a switch to n -type behavior. (e) and (f) Output characteristics of AIS(1ZnS/S)-FET and AIS(2ZnS/S)-FET after one and two cycles of ZnS treatment, respectively, and surface termination with S^{2-} . The devices retained their n -type behavior while the Zn treatment enhanced the electron mobility due to the passivation of acceptor sites. To confirm the behavior, five more FETs based on the surface-treated CIS and AIS QDs were fabricated (Table S5), which confirms the gradual increase in the carrier mobility with the number of treatment cycles.

CIS(1ZnS/S)- and CIS(2ZnS/S)-FETs are shown in Figure 4f,4g, respectively. The electron mobility of the device increases after one and two cycles of ZnS treatment to 2.29 and 5.53 $\text{cm}^2 \text{V}^{-1} \text{s}^{-1}$ in the saturation regime, respectively, which is more than five times higher than the CIS(S)-FETs. The increase is due to the diffusion of the Zn^{2+} ions into the lattice and replacement of V_{In} and V_{Cu} with Zn^{2+} ions or exchange of lower-valency Cu_{In} with Zn.

The origin of the charge transfer behavior and carrier mobility can be explained in terms of three factors of decreased hopping distance, negative charge doping, and nullification of the acceptor sites (Figure 5a). To better understand the applicability of surface treatment in enhancing the electronic properties of group I–III–VI QDs, FETs based on original and treated AIS QDs were fabricated. The transfer curve and the output characteristics of AIS-FETs in Figure 5b,5c, respectively, display the p -type behavior of the original QDs. However, unlike CIS-FETs, the AIS-FET exhibits degenerate behavior indicative of the excessive number of hole and acceptor sites. The output characteristics and transfer curve of AIS(S)-FET in Figure 5b,d, respectively, show that implementing the first S^{2-} layer causes n -doping of the device and increases carrier mobility to 2.06 $\text{cm}^2 \text{V}^{-1} \text{s}^{-1}$. Treating AIS QDs with Zn (Figure 5e) enhances electron mobility by decreasing the number of the acceptor sites, as apparent from the enhanced electron mobility with further surface treatment (Figure 5f). As for AIS QDs Zn concentration increases faster than the CIS QDs (Supporting Information), the final

AIS(2ZnS/S)-FETs demonstrate higher electron mobility compared to the CIS(2ZnS/S)-FETs.

Similarly, FETs based on CdS-treated CIS QDs display an initial switch from p -type to n -type behavior upon S^{2-} passivation and a secondary enhancement in μ_e with the first layer of CdS treatment due to the nullification of acceptor sites (detailed in the Supporting Information). Within the second cycle of cation treatment, the electron mobility slightly drops, suggesting no improvement in the passivation of acceptor sites. The highest μ_e for CdS-treated CIS-FETs is 6.13 $\text{cm}^2 \text{V}^{-1} \text{s}^{-1}$ (improved from 2.17 $\text{cm}^2 \text{V}^{-1} \text{s}^{-1}$) presented in Table 1. The experiments point to the possibility of Zn and Cd diffusion in the lattice and nullification of vacancy or antisite defects, as was shown by the chemical measurements earlier (Figures 3b and S4e), in which the cation exchange of the host ions also caused a blue shift in the PL spectra similar to a previous study.⁷³

CONCLUSIONS

In conclusion, a universal strategy toward surface and composition modification of group I–III–VI QDs was developed, in which the original QDs were consecutively treated with ZnS or CdS. The optical properties, including the PL peak wavelength and recombination dynamics, can be finely tuned with ZnS treatment, while CdS treatment demonstrates a much more immense impact on the optical properties due to its lower band offset and higher Cd activity. The QDs-FETs exhibit superior electronic properties due to a

combination of factors, including removal of bulky original ligands, inorganic passivation of the surface, injection of negative charge and nullification of acceptor antisite and vacancy defects after surface modification. CIS-based FETs possess a very high electron mobility of $5.53 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$, along with an on/off ratio in the order of 10^5 . The superior electronic performance of the I–III–VI-based FETs coupled with the larger absorption cross-section of the QDs can pave the way for developing high-performance photodetectors based on these QDs.

■ ASSOCIATED CONTENT

SI Supporting Information

The Supporting Information is available free of charge at <https://pubs.acs.org/doi/10.1021/acs.chemmater.5c00676>.

Synthesis and characterization methods, device fabrication and characterization, TRF decay components of ZnS-treated QDs and TRF decay curve of CIS/IS QDs, TEM images of CIS QDs, CdS Surface treatment of CIS QDs, ZnS surface treatment of AIS and CISE QDs, real images of half-layer reactions and phase transfer, cross-sectional SEM image of the device, AFM image of the device, FTIR spectra of QDs before and after ligand removal, time-dependent behavior of CIS-FET, device characteristics of extra samples, and output and transfer characteristics of CdS-treated CIS-based device (PDF)

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Notes

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